

# MOSFET – N-Channel, POWERTRENCH®

60 V, 100 A, 3 Ω

**FDMS030N06B**

## Description

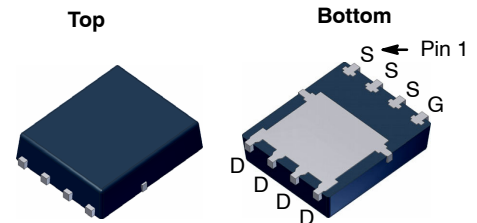
This N-Channel MOSFET is produced using onsemi's advance POWERTRENCH process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

## Features

- $R_{DS(on)} = 2.4\text{ m}\Omega$  (Typ) at  $V_{GS} = 10\text{ V}$ ,  $I_D = 50\text{ A}$
- Advanced Package and Silicon Combination for Low  $R_{DS(on)}$  and High Efficiency
- Fast Switching Speed
- 100% UIL Tested
- RoHS Compliant

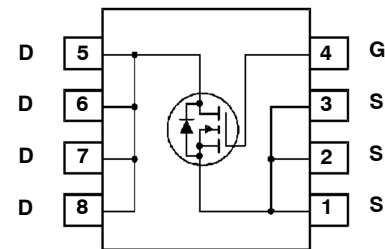
## Applications

- Synchronous Rectification for ATX / Server / Telecom PSU
- Battery Protection Circuit
- Motor drives and Uninterruptible Power Supplies
- Renewable system

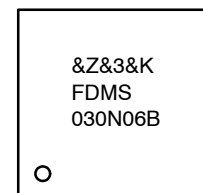


PQFN8 5 × 6, 1.27P  
(Power 56)  
CASE 483AE

## PIN CONNECTIONS



## MARKING DIAGRAM



&Z = Assembly Plant Code  
 &3 = 3-Digit Date Code  
 &K = 2-Digit Lot Run Traceability Code  
 FDMS030N06B = Specific Device Code

## ORDERING INFORMATION

| Device      | Package                            | Shipping <sup>†</sup> |
|-------------|------------------------------------|-----------------------|
| FDMS030N06B | PQFN8<br>(Pb-Free,<br>Halide Free) | 3000 /<br>Tape & Reel |

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, [BRD8011/D](http://www.onsemi.com/BRD8011/D).

# FDMS030N06B

## MAXIMUM RATINGS (T<sub>C</sub> = 25°C unless otherwise noted)

| Symbol                            | Parameter                                        |                      |                                    | FDMS030N06B | Unit |
|-----------------------------------|--------------------------------------------------|----------------------|------------------------------------|-------------|------|
| V <sub>DSS</sub>                  | Drain to Source Voltage                          |                      |                                    | 60          | V    |
| V <sub>GSS</sub>                  | Gate to Source Voltage                           |                      |                                    | ±20         | V    |
| I <sub>D</sub>                    | Drain Current                                    | Continuous (Note 1)  | T <sub>C</sub> = 25°C              | 100         | A    |
|                                   |                                                  | Continuous (Note 2a) | T <sub>A</sub> = 25°C              | 22.1        |      |
| I <sub>DM</sub>                   | Drain Current                                    | Pulsed (Note 3)      |                                    | 400         |      |
| E <sub>AS</sub>                   | Single Pulse Avalanche Energy (Note 4)           |                      |                                    | 248         | mJ   |
| P <sub>D</sub>                    | Power Dissipation                                |                      | T <sub>C</sub> = 25°C              | 104         | W    |
|                                   |                                                  |                      | T <sub>A</sub> = 25°C<br>(Note 2a) | 2.5         |      |
| T <sub>J</sub> , T <sub>STG</sub> | Operating and Storage Junction Temperature Range |                      |                                    | −55 to +150 | °C   |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

## THERMAL CHARACTERISTICS

| Symbol           | Parameter                                              | FDMS030N06B | Unit |
|------------------|--------------------------------------------------------|-------------|------|
| R <sub>θJC</sub> | Thermal Resistance, Junction to Case, Max              | 1.2         | °C/W |
| R <sub>θJA</sub> | Thermal Resistance, Junction to Ambient, Max (Note 2a) | 50          |      |

## ELECTRICAL CHARACTERISTICS (T<sub>C</sub> = 25°C unless otherwise noted)

| Symbol | Parameter | Test Condition | Min | Typ | Max | Unit |
|--------|-----------|----------------|-----|-----|-----|------|
|--------|-----------|----------------|-----|-----|-----|------|

### OFF CHARACTERISTICS

|                                      |                                           |                                                |    |      |      |      |
|--------------------------------------|-------------------------------------------|------------------------------------------------|----|------|------|------|
| BV <sub>DSS</sub>                    | Drain to Source Breakdown Voltage         | I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0 V | 60 | –    | –    | V    |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | I <sub>D</sub> = 250 μA, Referenced to 25°C    | –  | 0.03 | –    | V/°C |
| I <sub>DSS</sub>                     | Zero Gate Voltage Drain Current           | V <sub>DS</sub> = 48 V, V <sub>GS</sub> = 0 V  | –  | –    | 1    | μA   |
| I <sub>GSS</sub>                     | Gate to Body Leakage Current              | V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V | –  | –    | ±100 | nA   |

### ON CHARACTERISTICS

|                     |                                      |                                                             |     |     |     |    |
|---------------------|--------------------------------------|-------------------------------------------------------------|-----|-----|-----|----|
| V <sub>GS(th)</sub> | Gate to Source Threshold Voltage     | V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250 μA | 2.5 | 3.3 | 4.5 | V  |
| R <sub>DS(on)</sub> | Static Drain to Source On Resistance | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 50 A               | –   | 2.4 | 3.0 | mΩ |
| g <sub>FS</sub>     | Forward Transconductance             | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 50 A               | –   | 119 | –   | S  |

### DYNAMIC CHARACTERISTICS

|                      |                                   |                                                                                          |   |      |      |    |
|----------------------|-----------------------------------|------------------------------------------------------------------------------------------|---|------|------|----|
| C <sub>iss</sub>     | Input Capacitance                 | V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V, f = 1 MHz                                 | – | 5685 | 7560 | pF |
| C <sub>oss</sub>     | Output Capacitance                |                                                                                          | – | 1720 | 2290 | pF |
| C <sub>rss</sub>     | Reverse Transfer Capacitance      |                                                                                          | – | 59   | –    | pF |
| C <sub>oss(er)</sub> | Energy Related Output Capacitance | V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V                                            | – | 2504 | –    | pF |
| Q <sub>g(tot)</sub>  | Total Gate Charge at 10 V         | V <sub>DS</sub> = 30 V, I <sub>D</sub> = 50 A, V <sub>GS</sub> = 0 V to 10 V<br>(Note 5) | – | 75   | –    | nC |
| Q <sub>gs</sub>      | Gate to Source Gate Charge        |                                                                                          | – | 30   | –    | nC |
| Q <sub>gd</sub>      | Gate to Drain “Miller” Charge     |                                                                                          | – | 14   | –    | nC |
| V <sub>plateau</sub> | Gate Plateau Voltage              |                                                                                          | – | 5.4  | –    | V  |
| Q <sub>sync</sub>    | Total Gate Charge Sync            | V <sub>DS</sub> = 0 V, I <sub>D</sub> = 50 A                                             | – | 66.2 | –    | nC |
| Q <sub>oss</sub>     | Output Charge                     | V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V                                            | – | 174  | –    | nC |
| ESR                  | Equivalent Series Resistance      | f = 1 MHz                                                                                | – | 1.05 | –    | Ω  |

**ELECTRICAL CHARACTERISTICS** ( $T_C = 25^\circ\text{C}$  unless otherwise noted) (continued)

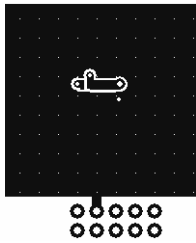
| Symbol                           | Parameter           | Test Condition                                                                                              | Min | Typ | Max | Unit |
|----------------------------------|---------------------|-------------------------------------------------------------------------------------------------------------|-----|-----|-----|------|
| <b>SWITCHING CHARACTERISTICS</b> |                     |                                                                                                             |     |     |     |      |
| $t_{d(on)}$                      | Turn-On Delay Time  | $V_{DD} = 30\text{ V}$ , $I_D = 50\text{ A}$ , $V_{GS} = 10\text{ V}$ ,<br>$R_{GEN} = 4.7\ \Omega$ (Note 5) | –   | 39  | 88  | ns   |
| $t_r$                            | Turn-On Rise Time   |                                                                                                             | –   | 20  | 50  | ns   |
| $t_{d(off)}$                     | Turn-Off Delay Time |                                                                                                             | –   | 52  | 114 | ns   |
| $t_f$                            | Turn-Off Fall Time  |                                                                                                             | –   | 16  | 42  | ns   |

**DRAIN-SOURCE DIODE CHARACTERISTICS**

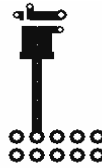
|          |                                                          |                                                                                          |   |    |      |    |
|----------|----------------------------------------------------------|------------------------------------------------------------------------------------------|---|----|------|----|
| $I_S$    | Maximum Continuous Drain to Source Diode Forward Current |                                                                                          | – | –  | 100  | A  |
| $I_{SM}$ | Maximum Pulsed Drain to Source Diode Forward Current     |                                                                                          | – | –  | 400  | A  |
| $V_{SD}$ | Drain to Source Diode Forward Voltage                    | $V_{GS} = 0\text{ V}$ , $I_{SD} = 50\text{ A}$                                           | – | –  | 1.25 | V  |
| $t_{rr}$ | Reverse Recovery Time                                    | $V_{GS} = 0\text{ V}$ , $I_{SD} = 50\text{ A}$ ,<br>$di_F/dt = 100\text{ A}/\mu\text{s}$ | – | 71 | –    | ns |
| $Q_{rr}$ | Reverse Recovery Charge                                  |                                                                                          | – | 85 | –    | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. Silicon limited  $I_D$  rating = 147 A.
2.  $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 × 1.5 in. board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



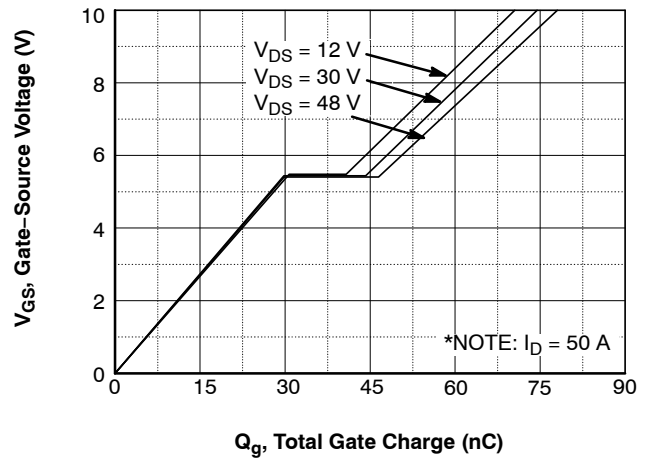
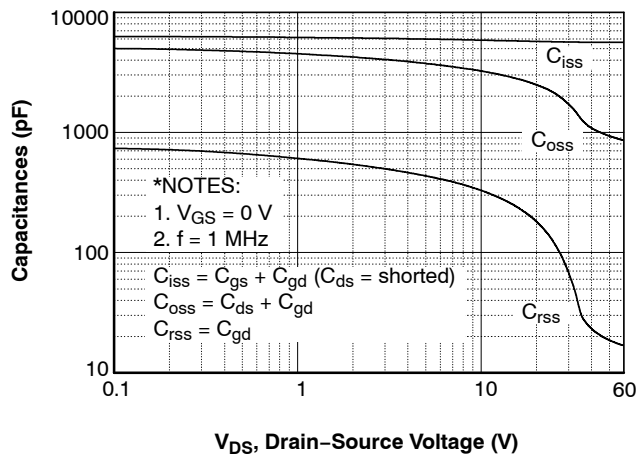
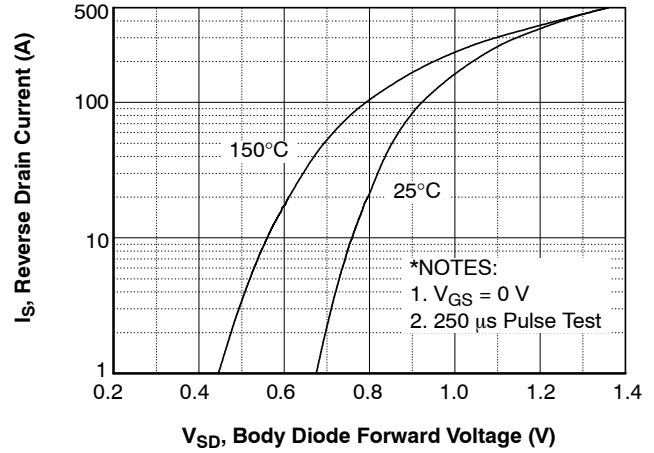
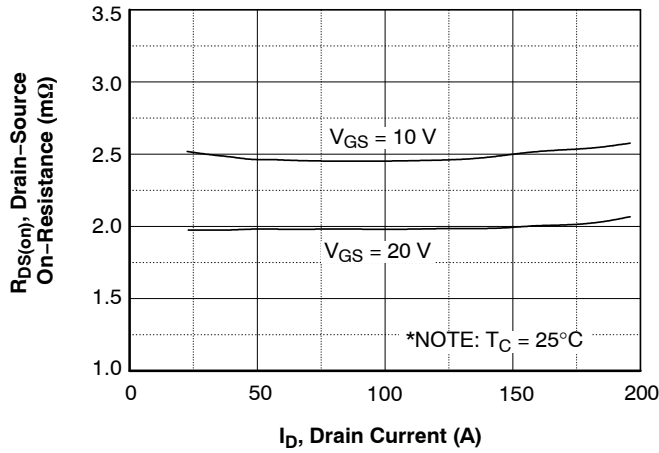
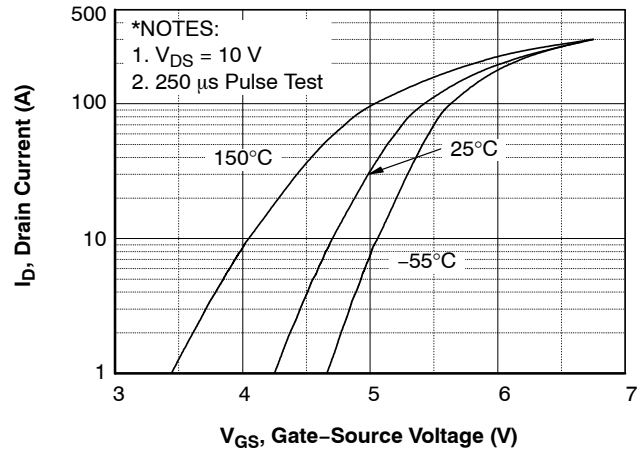
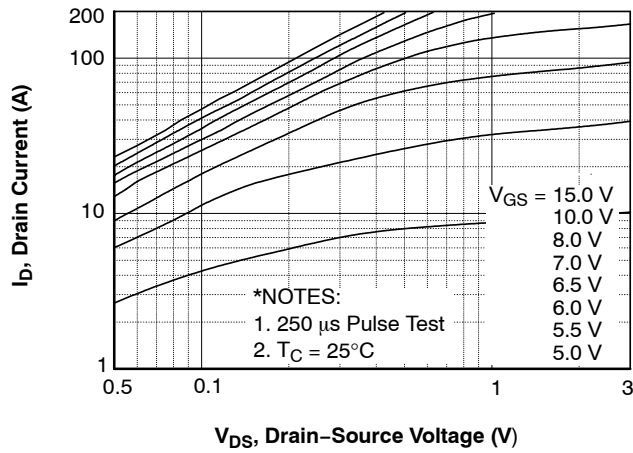
- a)  $50^\circ\text{C}/\text{W}$  when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



- b)  $125^\circ\text{C}/\text{W}$  when mounted on a minimum pad of 2 oz copper.

3. Repetitive rating: pulse-width limited by maximum junction temperature.
4.  $L = 0.3\text{ mH}$ ,  $I_{AS} = 40\text{ A}$ ,  $V_{DD} = 50\text{ V}$ ,  $V_{GS} = 10\text{ V}$ , starting  $T_J = 25^\circ\text{C}$ .
5. Essentially independent of operating temperature typical characteristics.

TYPICAL PERFORMANCE CHARACTERISTICS



TYPICAL PERFORMANCE CHARACTERISTICS (continued)

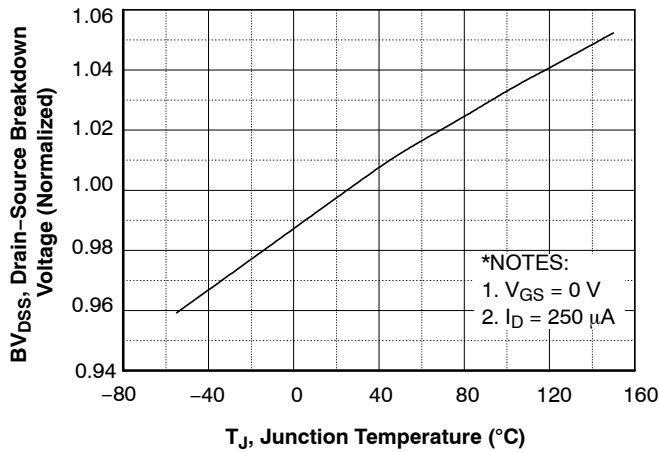


Figure 7. Breakdown Voltage Variation vs. Temperature

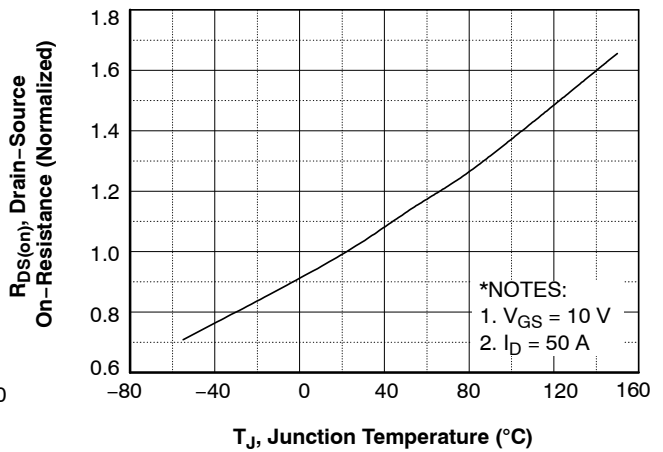


Figure 8. On-Resistance Variation vs. Temperature

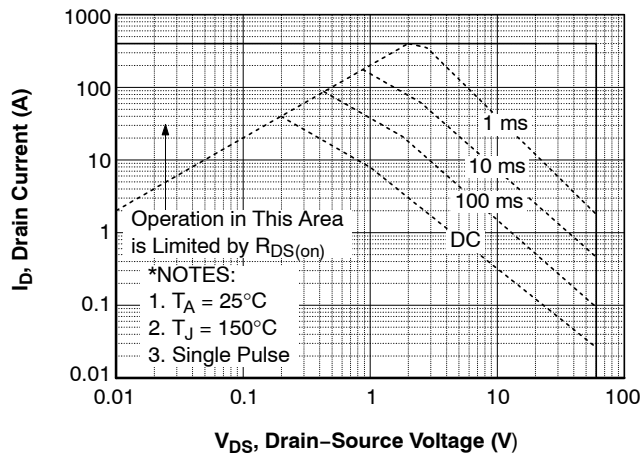


Figure 9. Maximum Safe Operating Area

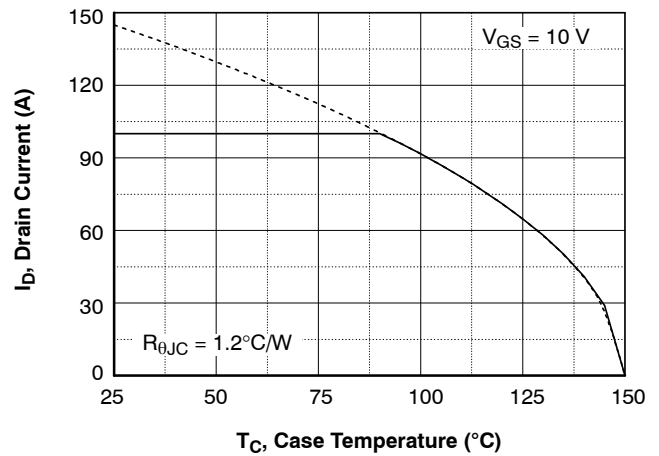


Figure 10. Maximum Drain Current vs. Case Temperature

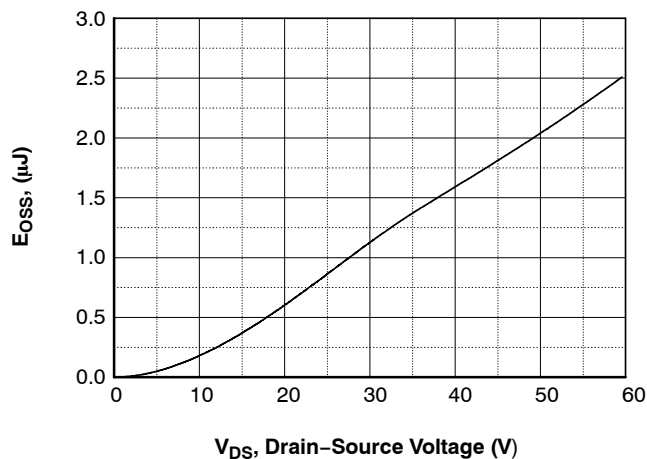


Figure 11.  $E_{oss}$  vs. Drain to Source Voltage

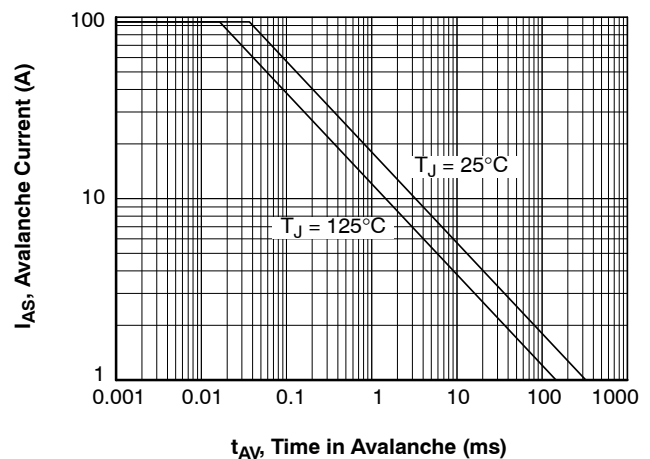


Figure 12. Unclamped Inductive Switching Capability

## TYPICAL PERFORMANCE CHARACTERISTICS (continued)

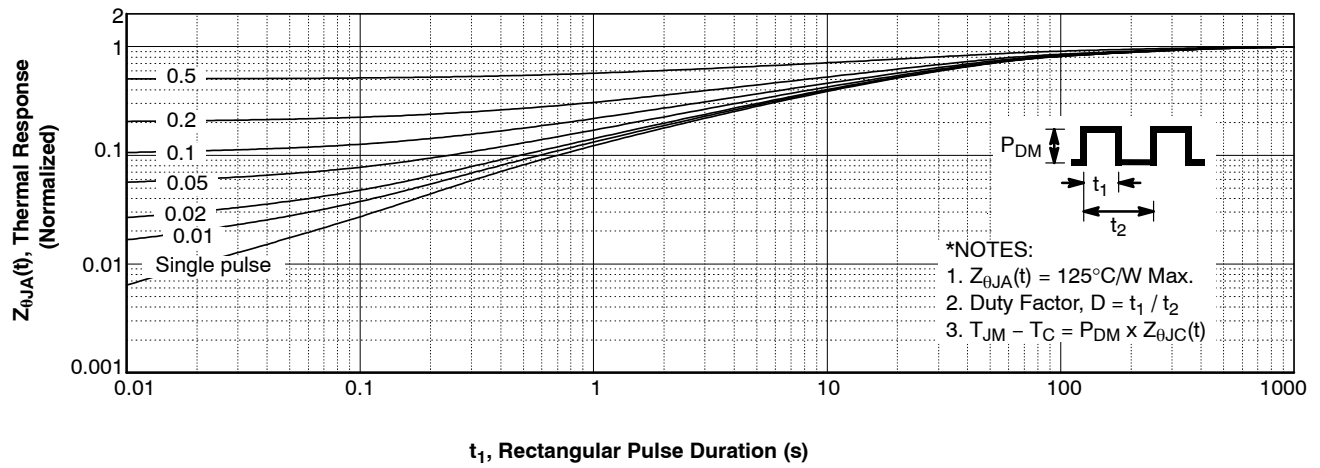


Figure 13. Transient Thermal Response Curve

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

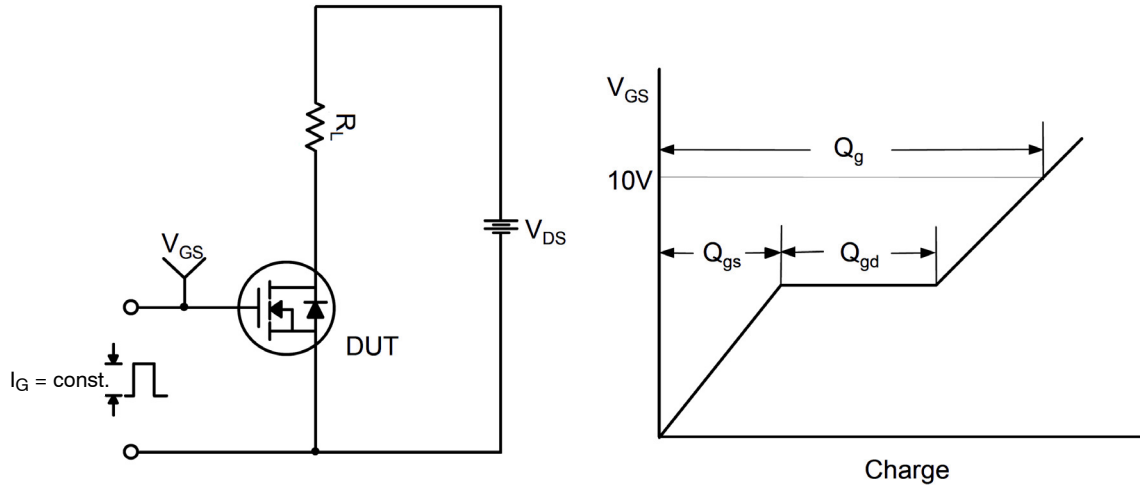


Figure 14. Gate Charge Test Circuit & Waveform

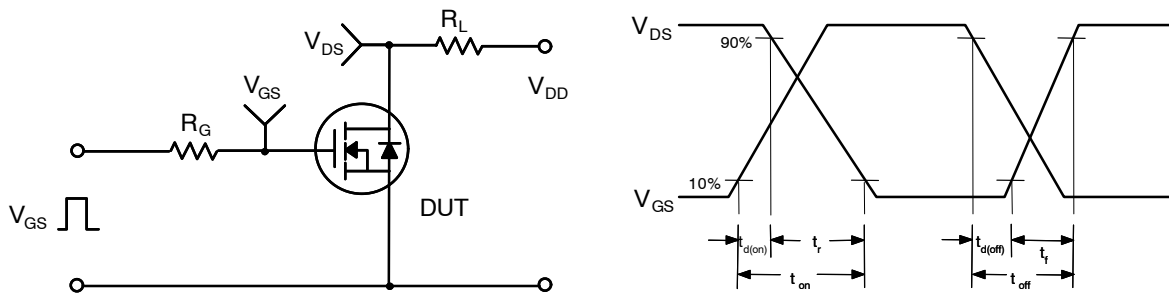


Figure 15. Resistive Switching Test Circuit & Waveforms

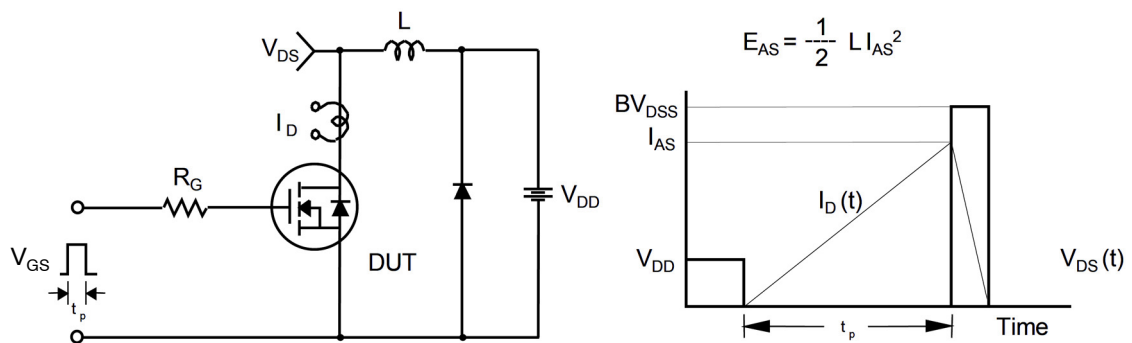
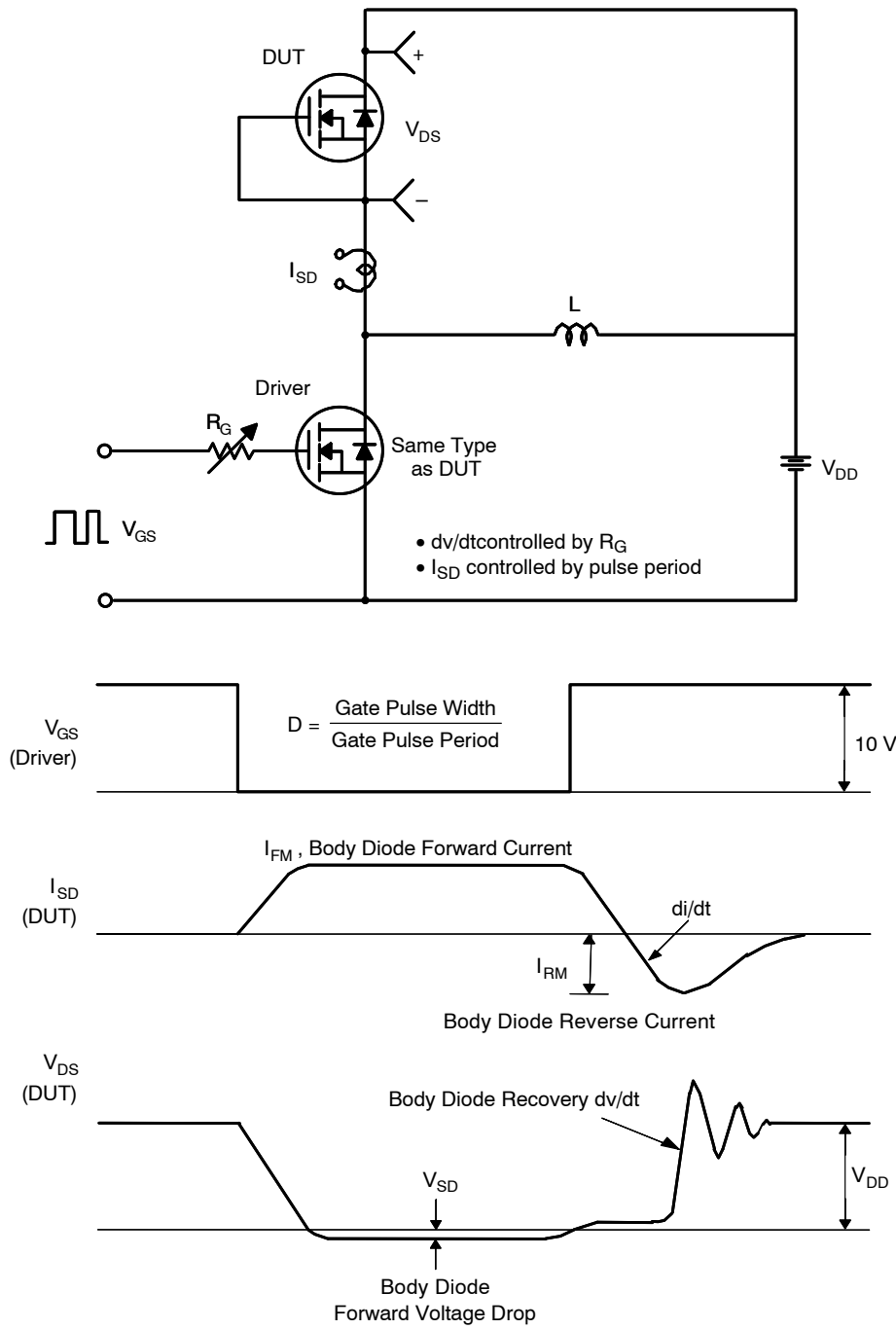


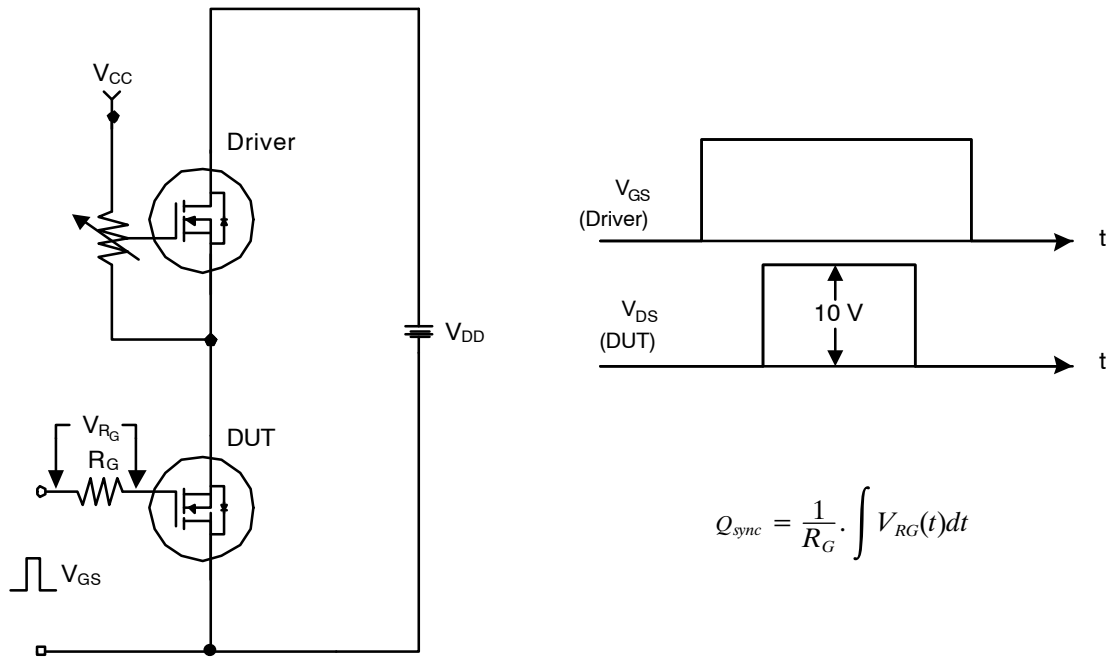
Figure 16. Unclamped Inductive Switching Test Circuit & Waveforms

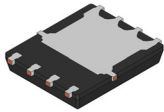
## TYPICAL PERFORMANCE CHARACTERISTICS (continued)

Figure 17. Peak Diode Recovery  $dv/dt$  Test Circuit & Waveforms



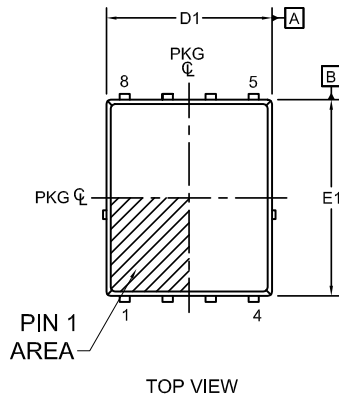
## TYPICAL PERFORMANCE CHARACTERISTICS (continued)

Figure 18. Total Gate Charge  $Q_{sync}$ . Test Circuit & Waveforms

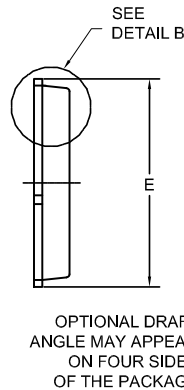


**PQFN8 5X6, 1.27P**  
**CASE 483AE**  
**ISSUE C**

DATE 21 JAN 2022



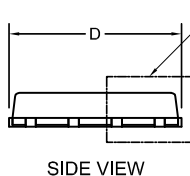
TOP VIEW



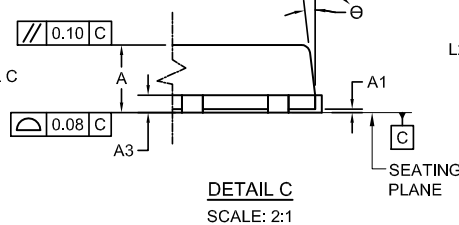
OPTIONAL DRAFT  
ANGLE MAY APPEAR  
ON FOUR SIDES  
OF THE PACKAGE

**NOTES:**

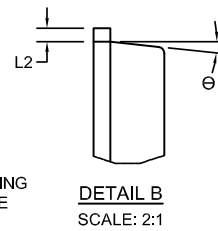
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
2. CONTROLLING DIMENSION: MILLIMETERS
3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
5. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
6. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.



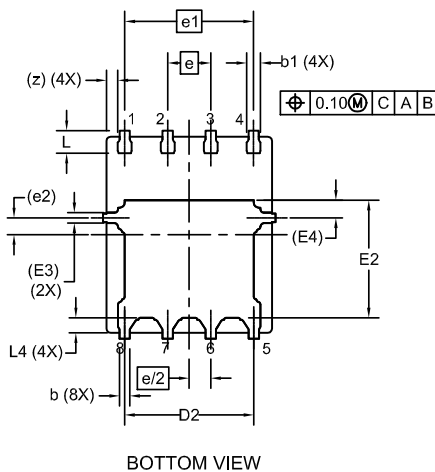
SIDE VIEW



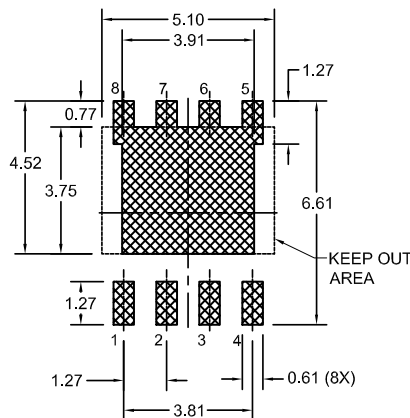
**DETAIL C**  
SCALE: 2:1



**DETAIL B**  
SCALE: 2:1



BOTTOM VIEW



**LAND PATTERN  
RECOMMENDATION**

\*FOR ADDITIONAL INFORMATION ON OUR  
PB-FREE STRATEGY AND SOLDERING  
DETAILS, PLEASE DOWNLOAD THE ON  
SEMICONDUCTOR SOLDERING AND  
MOUNTING TECHNIQUES REFERENCE  
MANUAL, SOLDERRM/D.

| DIM | MILLIMETERS |      |      |
|-----|-------------|------|------|
|     | MIN.        | NOM. | MAX. |
| A   | 0.90        | 1.00 | 1.10 |
| A1  | 0.00        | -    | 0.05 |
| b   | 0.21        | 0.31 | 0.41 |
| b1  | 0.31        | 0.41 | 0.51 |
| A3  | 0.15        | 0.25 | 0.35 |
| D   | 4.90        | 5.00 | 5.20 |
| D1  | 4.80        | 4.90 | 5.00 |
| D2  | 3.61        | 3.82 | 3.96 |
| E   | 5.90        | 6.15 | 6.25 |
| E1  | 5.70        | 5.80 | 5.90 |
| E2  | 3.38        | 3.48 | 3.78 |
| E3  | 0.30 REF    |      |      |
| E4  | 0.52 REF    |      |      |
| e   | 1.27 BSC    |      |      |
| e/2 | 0.635 BSC   |      |      |
| e1  | 3.81 BSC    |      |      |
| e2  | 0.50 REF    |      |      |
| L   | 0.51        | 0.66 | 0.76 |
| L2  | 0.05        | 0.18 | 0.30 |
| L4  | 0.34        | 0.44 | 0.54 |
| z   | 0.34 REF    |      |      |
| Θ   | 0°          | -    | 12°  |

**DOCUMENT NUMBER:** 98AON13655G

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**DESCRIPTION:** PQFN8 5X6, 1.27P

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